S	earch	Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/769,010	YOON ET AL	
Examiner	Art Unit	
AUMED ELALLANA	2616	

	SEAR	CHED	
Class	Subclass	Date	Examiner
370	228-231	12/18/2007	AE]
	235, 236		
	277, 280		
	282, 294		
	314		
	320-322		
	335		
	342, 441		
	477		
455	68		
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	515	*	P

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SEAF (INCLUDING S	RCH NOTES SEARCH STRATEGY)	
	DATE	EXMR
BRS(EAST)	12/17/2007	AE
BRS(EAST)	12/18/2007	AE
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